C9940: 3-Dimensional Transmission Electron Microscopy

Lecture 3: Analysis of electron micrographs

Content

- interaction of electrons with matter, radiation damage

- data acquisition, image filtering
- projection theorem
- image averaging in 2D
- principal component analysis

Interaction of electrons with specimen



Williams et al., TEM, Springer







mean free path



- mean free path of inelastic scattering in vitrified biological specimens: ~395nm

Radiation damage



Radiation damage



A B 25e/Å² 'excess' exposure

Glaser R. (2016), Meth. Enzym.

Glaser R. (2016), Meth. Enzym.

Radiation damage



Interaction of electrons with specimen





Peet et al., (2019) Ultramicroscopy







- data fom each position on the sample stored as a short movie
- compensation of sample radiation damage
- compensation of the sample motion during exposure



- beam induced motion (sample geometry, local)
- drift, vibration (external sources, global)

- data fom each position on the sample stored as a short movie
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- averaging of the movie into single image increase S/N
- compensation for the global and local motion between the frames minimize image blur, maximize high-res. Info
- dose-weighting frame filtering based on acquired radiation damage





additional local motion

- averaging of the movie into single image increase S/N
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aligned image

unaligned image



aligned image

unaligned image

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- application of adaptive per-frame low pass filter before averaging

Image filtering

unfiltered image



lowpass filtered (50A)



lowpass filtered (250A)



Image filtering

unfiltered image



lowpass filtered (50A)



bandpass filtered (1000,10A)





Image formation



Image formation



CTF
$$(\vec{s}) = -\sqrt{1 - A^2} \cdot \sin(\gamma(\vec{s})) - A \cdot \cos(\gamma(\vec{s}))$$

 $\gamma(\vec{s}) = \gamma(s, \theta) = -\frac{\pi}{2}C_s\lambda^3 s^4 + \pi\lambda z(\theta)s^2$

A – amplitude contrast

- $s-spatial\ frequency$
- Cs spherical abberation
- λ electron wavelength

z – defocus



Envelope function

- Finite source size

 $E_{\rm pc}(k) = \exp\left[-\pi^2 q^2 (k^3 C_{\rm s} \lambda^3 - \Delta z k \lambda)^2\right],$

- Energy spread (defocus)

$$E_{\rm es}(k) = \exp\left[-\frac{1}{16\ln 2} \pi^2 \delta z^2 k^4 \lambda^2\right],$$

- MTF of the camera

 $E_{\rm f}(k) = 1/[1 + (k/k_{\rm f})^2],$

- Generic envelope (drift, charging, multiple scattering)

 $E_{\rm g}(k) = \exp[-(k/k_{\rm g})^2],$



Envelope function

 $I(\mathbf{k}) = E_{\rm pc}(k)E_{\rm es}(k)E_{\rm f}(k)E_{\rm g}(k)H(k)\Phi(\mathbf{k}) + N(\mathbf{k}).$ e^{-Bk^2}







Low defocus



High defocus

Projection theorem



John O'Brien (1991). The New Yorker

Projection theorem





The 2D Fourier transform of the projection of a 3D density is a central section of the 3D Fourier transform of the density, perpendicular to the direction of projection.

Particles (regions of interest)





n=1

Particles (regions of interest)





Signal to noise ratio increases with square-root of *n*

Image alignment in 2D







Sum of unaligned particles



Image alignment in 2D



Cross correlation



Unnormalized CCC = $f_1g_1 + f_2g_2 + f_3g_3 + f_4g_4 + f_5g_5 + f_6g_6 + f_7g_7 + f_8g_8 + f_9g_9 + f_{10}g_{10} + f_{11}g_{11} + f_{12}g_{12} + f_{13}g_{13} + f_{14}g_{14} + f_{15}g_{15} + f_{16}g_{16}$

Cross correlation



Image f

Image g

Unnormalized CCC = $f_1g_1 + f_2g_2 + f_3g_3 + f_4g_4 + f_5g_5 + f_6g_6 + f_7g_7 + f_8g_8 + f_9g_9 + f_{10}g_{10} + f_{11}g_{11} + f_{12}g_{12} + f_{13}g_{13} + f_{14}g_{14} + f_{15}g_{15} + f_{16}g_{16}$

Cross correlation coefficient



If the alignment is perfect, the cross-correlation coefficient will be 1

Cross correlation



Cross correlation



(2, 0)

Cross correlation function in 1D



Cross correlation function in 1D



$$F \circ I(x) = \sum_{i=-N}^{N} F(i)I(x+i)$$

Cross correlation function in 2D

$$F \circ I(x, y) = \sum_{j=-N}^{N} \sum_{i=-N}^{N} F(i, j) I(x+i, y+j)$$

Cross correlation function in 2D

$$F \circ I(x, y) = \sum_{j=-N}^{N} \sum_{i=-N}^{N} F(i, j) I(x+i, y+j)$$

$$F * I(x, y) = \sum_{j=-N}^{N} \sum_{i=-N}^{N} F(i, j) I(x - i, y - j)$$

Convolution

Cross correlation function in 2D

$$F \circ I(x, y) = \sum_{j=-N}^{N} \sum_{i=-N}^{N} F(i, j) I(x+i, y+j)$$

$$F * I(x, y) = \sum_{j=-N}^{N} \sum_{i=-N}^{N} F(i, j) I(x - i, y - j)$$

Convolution

FT(F*I) = FT(F) . FT(I) $FT(F \circ I) = FT(F)* . FT(I)$ Convolution theorem

Cross correlation function











We take a series of rings from each image, unravel them, and compute a series of 1D cross-correlation functions.

Shifts along these unraveled CCFs is equivalent to a rotation in Cartesian space.



Noise added









- after rotation





Image alignment in 2D



Translational and orientation alignment are interdependent

SOLUTION: You try a set of reasonable shifts, and perform separate orientation alignments for each.

Image alignment in 2D



Set of all shifts of up to 1 pixel Set of all new shifts of up to 2 pixels Shifts of (0, +/-1, +/-2) pixels results in 25 orientation searches.

Shift



Suppose we shift the image in x & y. The new pixels will be weighted averages of the old pixels. The more the mix the pixels, the worse the result will be.

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The Fourier transform of noise is noise

- "White" noise is evenly distributed in Fourier space
- "White" means that each pixel is independent



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The degradation of the images means that we should minimize the number of interpolations.





Frank (1996), J.Microscopy





Frank (1996), J.Microscopy

Classification methods are divided into those that are "supervised" and those which are "unsupervised":

- Supervised: divide or categorize according to similarity with "template" or "reference" (e.g. projection mathing
- Unsupervised: divide according to intrinsic properties (e.g. find classess of projections representing the same view

Classification

Reference based alignment



Multivariate data analysis (MDA) or multivariate statistical analysis (MSA)

- find new coordinate system tailored to the data

- find a space with reduced dimensionality for the representation of the objects. This greatly simplifies classification.

eigenvectors

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eigenimages

Principle component analysis (PCA), Correspondence analysis (CA)

8 classes of faces, 64x64 pixels

With noise added

Average:

Principle component analysis (PCA), Correspondence analysis (CA)

For a 4096-pixel image, we will have a 4096x4096 covariance matrix.

Row-reduction of the covariance matrix gives us "eigenvectors."

- The eigenvectors describe correlated variations in the data.
- The eigenvectors have 4096 elements and can beconverted back into images, called "eigenimages."
- The first eigenvectors will account for the most variation. The later eigenvectors may only describe noise.
- Linear combinations of these images will give us approximations of the classes that make up the data.

eigenimages

Principle component analysis (PCA), Correspondence analysis (CA)

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